

Comparison of (N+1) redundancy and fault tolerance approaches in single-stage series-connected isolated MVAC to LVDC converters

Bakeer, Abualkasim Ahmed Ali; Chub, Andrii; Blinov, Andrei; Bayhan, Sertac; **Vinnikov, Dmitri** 2023 International Conference on Clean Electrical Power (ICCEP) 2023 / p. 469-474 : ill <https://doi.org/10.1109/ICCEP57914.2023.10247478>

Fault diagnosis of output-side diode-bridge in isolated DC-DC series resonant converter

Bakeer, Abualkasim Ahmed Ali; Chub, Andrii; Vinnikov, Dmitri 2022 IEEE 7th International Energy Conference (ENERGYCON) 2022 <https://doi.org/10.1109/ENERGYCON53164.2022.9830339>

Fault-tolerant approach for photovoltaic module-level power electronic applications

Vinnikov, Dmitri; Chub, Andrii; Korkh, Oleksandr; Malinowski, Mariusz 2020 IEEE 14th International Conference on Compatibility, Power Electronics and Power Engineering (CPE-POWERENG) : proceedings 2020 / p. 438-444 : ill <https://doi.org/10.1109/CPE-POWERENG48600.2020.9161599>

Fault-tolerant bidirectional series resonant DC-DC converter with minimum number of components

Vinnikov, Dmitri; Chub, Andrii; Korkh, Oleksandr; Malinowski, Mariusz 2019 IEEE Energy Conversion Congress and Exposition, ECCE, 2019-09-29 - 2019-10-03, Baltimore, MD, USA 2019 / p. 1359–1363 <https://doi.org/10.1109/ECCE.2019.8912292>

Fault-tolerant control allocation for a bio-inspired underactuated AUV in the presence of actuator failures : design and experiments

Remmas, Mohamed Walid; Chemori, Ahmed; **Kruusmaa, Maarja** Ocean engineering 2023 / art. 115327, 10 p. : ill <https://doi.org/10.1016/j.oceaneng.2023.115327> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Fault-tolerant scheduling of mixed-critical applications on multi-processor platforms

Bagheri, Mehrdad; **Jervan, Gert** 2014 International Conference on Embedded and Ubiquitous Computing : EUC 2014 : 26-28 August 2014, Milano, Italy : proceedings 2014 / p. 25-32 : ill

Logic-based implementation of fault-tolerant routing in 3D Network-on-Chips

Niazmand, Behrad; Azad, Siavoosh Payandeh; Flich, Jose; **Raik, Jaan; Jervan, Gert; Hollstein, Thomas** 2016 Tenth IEEE/ACM International Symposium on Networks-on-Chip (NOCS) : Nara, Japan, 31 August - 2 September 2016 2016 / [8] p. : ill <https://doi.org/10.1109/NOCS.2016.7579317>

Understanding fault-tolerance vulnerabilities in advanced SoC FPGAs for critical applications

Cherezova, Natalia; Shibin, Konstantin; Jenihhin, Maksim; Jutman, Artur Microelectronics reliability 2023 / art. 115010, 10 p. : ill <https://doi.org/10.1016/j.microrel.2023.115010> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)